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Substitute for form 1449A/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Application Number	08/943,238
				Filing Date	October 3, 1997
				First Named Inventor	Masaaki HIROKI et al.
				Group Art Unit	2814
				Examiner Name	S. Rao
Sheet	1	of	1	Attorney Docket Number	0756-1724

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
st		5,572,345		Yamazaki et al.	11/05/1996	RECEIVED FEB 04 2004 OFFICE OF PETITIONS

FOREIGN PATENT DOCUMENTS								
Examiner Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Office ³	Number ⁴	Kind Code ⁵ (if known)				
st		JP	62-210422			09/16/1987		AB
st		JP	62-247330			10/28/1987		AB
st		JP	01-292315			11/24/1989		AB

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

Examiner Signature		Date Considered	8/5/04
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¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. ASMEX.387A	APPLICATION NO. 10/074,634
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)		APPLICANT Michael A. Todd	
		FILING DATE February 11, 2002	GROUP 2814

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
7. SN	5,214,002	05/25/93	Hayashi et al.			
2. SN	5,356,821	10/18/94	Naruse et al.			
3. SN	5,471,330	11/28/95	Sarma			
4. SN	6,103,600	08/15/00	Ueda et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
5. SN	11317530	16-11-99	Japan (abstract)			X	
6. SN	EP 0368651 A2	16-05-90					
7. SN	EP 0486047 A2	20-05-92					
8. SN	EP 0747974 A2	11-12-96					
9. SN	EP 1065728 A2	03-01-01					
10. SN	GB 2332564 A	23-06-99	United Kingdom				

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
11. SN	Olivares, J. et al.; "Solid-phase crystallization of amorphous SiGe films deposited by LPCVD on SiO ₂ and glass," Thin Solid Films 337 (1999) pp. 51-54.

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EXAMINER	DATE CONSIDERED
9/23/2004	9/23/2004
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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)	
C	1	V. Z-Q Li <i>et al.</i> , Appl. Phys. Lett. 71(23) 3388-90 (1997)
	2	T-J King <i>et al.</i> , J. Electrochem. Soc., 141(8) 2235-41 (1994)
	3	A. Kovalgin <i>et al.</i> , ProRISC/IEEE 311-17 (1998)
	4	C. Hernandez <i>et al.</i> , Mat. Res. Soc. Symp. Proc. 533 93-98 (1998)
	5	M. Cao <i>et al.</i> , J. Electrochem. Soc., 142(5) 1566-72 (1995)
	6	J. Holleman <i>et al.</i> , J. Electrochem. Soc. 140(6) 1717-22 (1993)

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EXAMINER <u>9</u>	DATE CONSIDERED <u>9/23/2004</u>
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